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Sheet <u>1</u> of <u>1</u>

| Substitute Form PTO-1449 (Modified) | and a special period of the special sp | | Application No. 10/571,871 | |
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| Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b)) | | Applicant Paul Boyle et al. | | |
| | | Filing Date March 15, 2006 | Group Art Unit | |

| U.S. Patent Documents | | | | | | | |
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| Examiner Initial | Desig. ID | Document Number | Publication Date | Patentee | Class | Subclass | Filing Date If Appropriate |
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| Initial | ID | Number | Date | Patent Office | Class | Subclass | Yes | No |
| | AD | WO 2001/35441 | 05/17/01 | WIPO | | | | |
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| | AJ | | | |

| Examiner Signature /Meenakshi Sahu/ | Date Considered 05/09/2008 | | | | |
|---|----------------------------|--|--|--|--|
| EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with | | | | | |